Preferred Device

# **Sensitive Gate Silicon Controlled Rectifiers**

# **Reverse Blocking Thyristors**

Designed for high volume, low cost, industrial and consumer applications such as motor control; process control; temperature, light and speed control.

#### **Features**

- Small Size
- Passivated Die for Reliability and Uniformity
- Low Level Triggering and Holding Characteristics
- Epoxy Meets UL 94 V-0 @ 0.125 in
- ESD Ratings: Human Body Model, 3B > 8000 V

Machine Model, C > 400 V

• Pb-Free Packages are Available

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1) (T <sub>J</sub> = -40 to 110°C, Sine Wave, 50 to 60 Hz, Gate Open)  MCR12DSM  MCR12DSN	V <sub>DRM,</sub> V <sub>RRM</sub>	600 800	>
On–State RMS Current (180° Conduction Angles; T <sub>C</sub> = 75°C)	I <sub>T(RMS)</sub>	12	Α
Average On–State Current (180° Conduction Angles; T <sub>C</sub> = 75°C)	I <sub>T(AV)</sub>	7.6	Α
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T <sub>J</sub> = 110°C)	I <sub>TSM</sub>	100	Α
Circuit Fusing Consideration (t = 8.3 msec)	l <sup>2</sup> t	41	A <sup>2</sup> sec
Forward Peak Gate Power (Pulse Width $\leq$ 1.0 $\mu$ sec, T <sub>C</sub> = 75°C)	$P_{GM}$	5.0	W
Forward Average Gate Power (t = 8.3 msec, T <sub>C</sub> = 75°C)	P <sub>G(AV)</sub>	0.5	W
Forward Peak Gate Current (Pulse Width ≤ 1.0 µsec, T <sub>C</sub> = 75°C)	I <sub>GM</sub>	2.0	А
Operating Junction Temperature Range	TJ	-40 to 110	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to 150	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the device are exceeded.



# ON Semiconductor®

http://onsemi.com

# SCRs 12 AMPERES RMS 600 – 800 VOLTS



#### MARKING DIAGRAMS

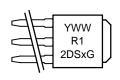


DPAK CASE 369C STYLE 4





DPAK-3 CASE 369D STYLE 4



PIN ASSIGNMENT				
1	Cathode			
2	Anode			
3	Gate			
4	Anode			

# **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

**Preferred** devices are recommended choices for future use and best overall value.

#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, – Junction–to–Case  – Junction–to–Ambient  – Junction–to–Ambient (Note 2)	R <sub>θ</sub> JC R <sub>θ</sub> JA R <sub>θ</sub> JA	2.2 88 80	°C/W
Maximum Lead Temperature for Soldering Purposes (Note 3)	$T_L$	260	°C

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Characteristics	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Peak Repetitive Forward or Reverse Blocking Current (Note 4) $(V_{AK} = \text{Rated V}_{DRM} \text{ or V}_{RRM}; \ R_{GK} = 1.0 \ \text{K}\Omega) \qquad \qquad T_J = 25^{\circ}\text{C} \\ T_J = 110^{\circ}\text{C}$		I <sub>DRM</sub> , I <sub>RRM</sub>	_ _	_ _	10 500	μΑ
N CHARACTERISTICS		•	•	-	<u>-</u>	='
Peak Reverse Gate Blocking Voltage, ( $I_{GR} = 10 \mu A$ )		$V_{GRM}$	10	12.5	18	V
Peak Reverse Gate Blocking Current, (V <sub>GR</sub> = 10 V)		I <sub>GRM</sub>	_	-	1.2	μΑ
Peak Forward On-State Voltage (Note 5), (I <sub>TM</sub> = 20 A)		$V_{TM}$	_	1.3	1.9	V
Gate Trigger Current (Continuous dc) (Note 6) $(V_D = 12 \text{ V}, \text{ R}_L = 100 \Omega)$	$T_J = 25$ °C $T_J = -40$ °C	I <sub>GT</sub>	5.0	12 -	200 300	μΑ
Gate Trigger Voltage (Continuous dc) (Note 6) $(V_D = 12 \text{ V}, \text{ R}_L = 100 \ \Omega)$	$T_J = 25^{\circ}C$ $T_J = -40^{\circ}C$ $T_J = 110^{\circ}C$	V <sub>GT</sub>	0.45 - 0.2	0.65 - -	1.0 1.5 –	V
Holding Current (V <sub>D</sub> = 12 V, Initiating Current = 200 mA, Gate Open)	$T_{J} = 25^{\circ}C$ $T_{J} = -40^{\circ}C$	lн	0.5 -	1.0 -	6.0 10	mA
Latching Current $(V_D = 12 \text{ V}, I_G = 2.0 \text{ mA})$	$T_J = 25$ °C $T_J = -40$ °C	IL	0.5	1.0	6.0 10	mA
Turn–On Time (Source Voltage = 12 V, $R_S = 6.0 \text{ K}\Omega$ , $I_T = 16 \text{ A(pk)}$ , $R_C = 0.0 \text{ K}\Omega$ , $R_C =$	tgt	-	2.0	5.0	μS	
YNAMIC CHARACTERISTICS						
Critical Rate of Rise of Off–State Voltage ( $V_D = 0.67 \times Rated V_{DRM}$ , Exponential Waveform, $R_{GK} = 1.0 \times R_{J} = 110^{\circ}C$ )		dv/dt	2.0	10	_	V/µs

These ratings are applicable when surface mounted on the minimum pad sizes recommended.

<sup>3. 1/8&</sup>quot; from case for 10 seconds.

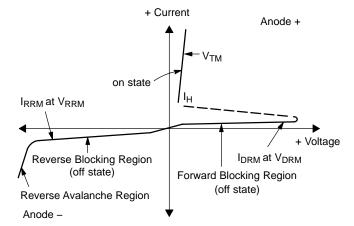
<sup>4.</sup> Ratings apply for negative gate voltage or R<sub>GK</sub> = 1.0 kΩ. Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.

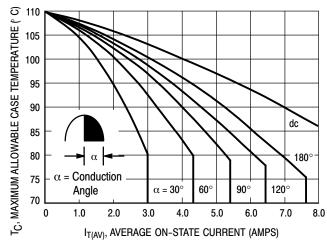
<sup>5.</sup> Pulse Test: Pulse Width ≤ 2.0 msec, Duty Cycle ≤ 2%.

<sup>6.</sup> R<sub>GK</sub> current not included in measurement.

# **Voltage Current Characteristic of SCR**

Symbol	Parameter
$V_{DRM}$	Peak Repetitive Off State Forward Voltage
I <sub>DRM</sub>	Peak Forward Blocking Current
$V_{RRM}$	Peak Repetitive Off State Reverse Voltage
I <sub>RRM</sub>	Peak Reverse Blocking Current
$V_{TM}$	Peak On State Voltage
I <sub>H</sub>	Holding Current





P(AV), AVERAGE POWER DISSIPATION (WATTS) 180° 120° 14 90° 12 60° dc  $\alpha = \text{Conduction}$ 10 Angle 8.0  $\alpha = 30^{\circ}$ 6.0 4.0 2.0 0 3.0 4.0 5.0 7.0 8.0 I<sub>T(AV)</sub>, AVERAGE ON-STATE CURRENT (AMPS)

Figure 1. Average Current Derating

Figure 2. On-State Power Dissipation

1.0

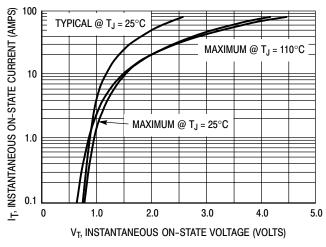
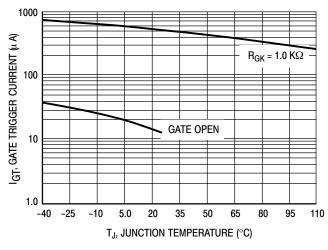


Figure 3. On-State Characteristics

Figure 4. Transient Thermal Response



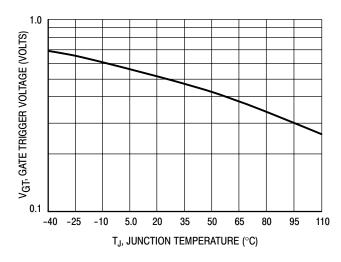
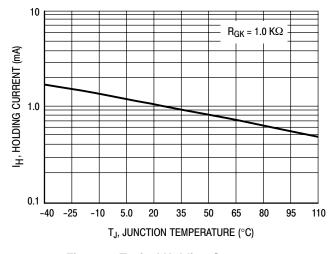


Figure 5. Typical Gate Trigger Current versus Junction Temperature

Figure 6. Typical Gate Trigger Voltage versus
Junction Temperature



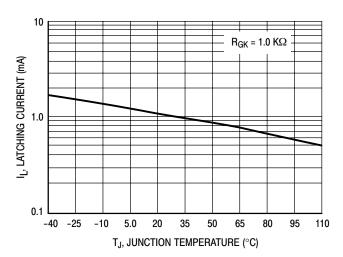


Figure 7. Typical Holding Current versus Junction Temperature

Figure 8. Typical Latching Current versus Junction Temperature

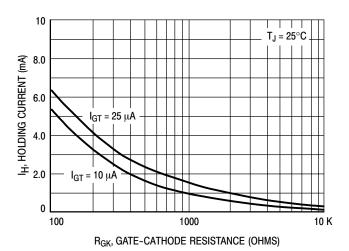
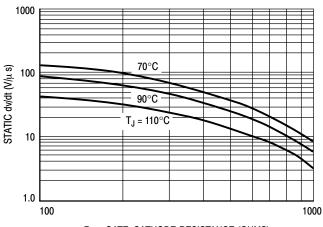
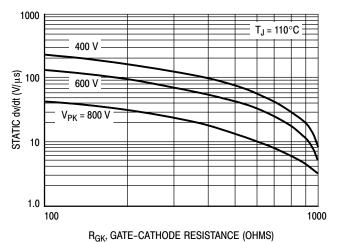


Figure 9. Holding Current versus



R<sub>GK</sub>, GATE-CATHODE RESISTANCE (OHMS)

Figure 10. Exponential Static dv/dt versus **Gate-Cathode Resistance Gate-Cathode Resistance and Junction Temperature** 



1000  $V_D = 800 V$  $T_J = 110^{\circ}C$ STATIC dv/dt (V/µs) 100  $I_{GT} = 25 \mu A$  $I_{GT} = 10 \mu A$ 10 1.0 100 1000

R<sub>GK</sub>, GATE-CATHODE RESISTANCE (OHMS)

Figure 11. Exponential Static dv/dt versus Gate-Cathode Resistance and Peak Voltage

Figure 12. Exponential Static dv/dt versus **Gate-Cathode Resistance and Gate Trigger Current Sensitivity** 

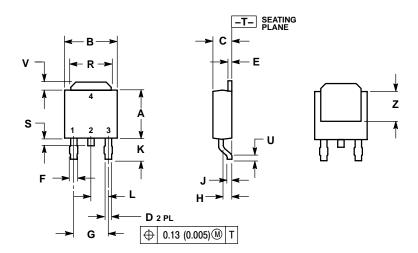
#### **ORDERING INFORMATION**

Device	Package Type	Package	Shipping <sup>†</sup>
MCR12DSMT4	DPAK	369C	2500 / Tape & Reel
MCR12DSMT4G	DPAK (Pb-Free)	369C	2500 / Tape & Reel
MCR12DSN-001	DPAK-3	369D	75 Units / Rail
MCR12DSN-001G	DPAK-3 (Pb-Free)	369D	75 Units / Rail
MCR12DSNT4	DPAK	369C	2500 / Tape & Reel
MCR12DSNT4G	DPAK (Pb-Free)	369C	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **PACKAGE DIMENSIONS**

#### **DPAK** CASE 369C **ISSUE O**

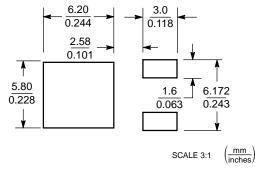


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180 BSC		4.58	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE

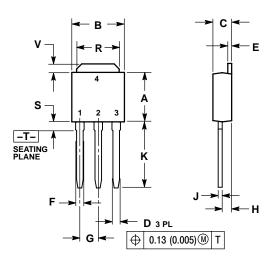
# **SOLDERING FOOTPRINT\***

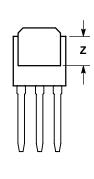


<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

DPAK-3 CASE 369D-01 **ISSUE B** 





#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETER	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	0.090 BSC		BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 4

PIN 1. CATHODE

- 2. ANODE 3. GATE
- ANODE

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